

# LC<sup>2</sup>MOS Parallel Loading Dual 12-Bit DAC

**AD7547** 

#### **FEATURES**

Two 12-Bit DACs in One Package
DAC Ladder Resistance Matching: 0.5%
Space Saving Skinny DIP and Surface
Mount Packages
4-Quadrant Multiplication
Low Gain Error (1LSB max Over Temperature)
Fast Interface Timing

APPLICATIONS
Automatic Test Equipment
Programmable Filters
Audio Applications
Synchro Applications
Process Control

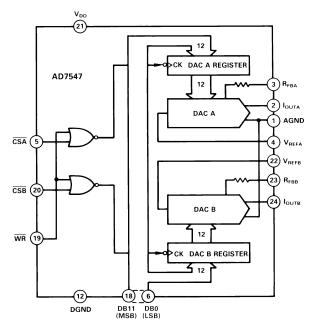
#### **GENERAL DESCRIPTION**

The AD7547 contains two 12-bit current output DACs on one monolithic chip. Also on-chip are the level shifters, data registers and control logic for easy microprocessor interfacing. There are 12 data inputs.  $\overline{CSA}$ ,  $\overline{CSB}$ ,  $\overline{WR}$  control DAC selection and loading. Data is latched into the DAC registers on the rising edge of  $\overline{WR}$ . The device is speed compatible with most microprocessors and accepts TTL, 74HC and 5V CMOS logic level inputs.

The D/A converters provide 4-quadrant multiplication capabilities with separate reference inputs and feedback resistors. Monolithic construction ensures that thermal and gain error tracking is excellent. 12-bit monotonicity is guaranteed for both DACs over the full temperature range.

The AD7547 is manufactured using the Linear Compatible CMOS (LC<sup>2</sup>MOS) process. This allows fast digital logic and precision linear circuitry to be fabricated on the same die.

#### FUNCTIONAL BLOCK DIAGRAM



#### PRODUCT HIGHLIGHTS

#### 1. DAC to DAC Matching

Since both DACs are fabricated on the same chip, precise matching and tracking is inherent. Many applications which are not practical using two discrete DACs are now possible. Typical matching: 0.5%.

#### 2. Small Package Size

The AD7547 is available in 0.3" wide 24-pin DIPs and SOICs and in 28-terminal surface mount packages.

#### 3. Wide Power Supply Tolerance

The device operates on a +12V to +15V  $V_{\rm DD}$ , with  $\pm 10\%$  tolerance on this nominal figure. All specifications are guaranteed over this range.

## **AD7547\* Product Page Quick Links**

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## Comparable Parts

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### Documentation <a>□</a>

#### **Application Notes**

- AN-137: A Digitally Programmable Gain and Attenuation Amplifier Design
- AN-206: CMOS Multiplying DAC Based Panning Circuit Provides Almost Constant Output Power
- AN-209: 8th Order Programmable Low-Pass Analog Filter Using Dual 12-Bit CMOS Multiplying DACs
- AN-214: Ground Rules for High Speed Circuits
- AN-225: 12-Bit Voltage-Output DACs for Single-Supply 5V and 12V Systems
- AN-320A: CMOS Multiplying DACs and Op Amps Combine to Build Programmable Gain Amplifier, Part 1
- AN-348: Avoiding Passive-Component Pitfalls
- AN-912: Driving a Center-Tapped Transformer with a Balanced Current-Output DAC

#### **Data Sheet**

- AD7547: Dual 12-Bit CMOS DAC with Parallel Load Input Structure Data Sheet
- AD7547: Military Data Sheet

### Reference Materials

#### **Solutions Bulletins & Brochures**

• Digital to Analog Converters ICs Solutions Bulletin

## Design Resources <a>□</a>

- AD7547 Material Declaration
- PCN-PDN Information
- · Quality And Reliability
- · Symbols and Footprints

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# $\begin{array}{l} \textbf{AD7547} - \textbf{SPECIFICATIONS}^1 \ \, \stackrel{(V_{DD}\ =\ +12V\ to\ +15V,\ \pm10\%,\ V_{REFA}\ =\ V_{REFB}\ =\ 10V;\ I_{OUTA}\ =\ I_{OUTB}\ =\ AGND \\ =\ 0V.\ All\ specifications\ T_{min}\ to\ T_{max}\ unless\ otherwise\ specified.) \end{array}$

| Parameter  | J, A Versions | K, B Versions | L, C Versions | S Version | T Version  | U Version | Units       | Test Conditions/Comments  |
|--|---------------|---------------|---------------|-----------|--|-----------|-------------|---|
| ACCURACY   |               |               |               |           | †  |           |             |   |
| Resolution                                       | 12            | 12            | 12            | 12        | 12   | 12        | Bits        |   |
| Relative Accuracy                                | ±1            | ± 1/2         | ± 1/2         | ± 1       | ± 1/2  | ± 1/2     | LSB max     |   |
| Differential Nonlinearity                        | ±1            | ±1            | ± 1           | ±1        | ± 1  | ± 1       | LSB max     | All grades guaranteed monotonic over temperature.   |
| Gain Error                                       | ±6            | ± 3           | ± 1           | ± 6       | ± 3  | = 2       | LSB max     | Measured using R <sub>FBA</sub> , R <sub>FBB</sub> .  Both DAC registers loaded with all 1's. |
| Gain Temperature Coefficient <sup>2</sup> ;      |               | l             |               |           |  | 1         |             |   |
| ∆Gain/∆Temperature                               | ± 5           | ± 5           | ± 5           | ± 5       | ± 5  | ± 5       | ppm/°C max  | Typical value is 1ppm/°C  |
| Output Leakage Current                           |               |               |               |           |  |           |             | • • • • • • • • • • • • • • • • • • •   |
| I <sub>OUTA</sub>                                |               |               |               |           |  | 1         |             |   |
| + 25°C   | 10            | 10            | 10            | 10        | 10   | 10        | nA max      | DAC A Register loaded   |
| $T_{min}$ to $T_{max}$                           | 150           | 150           | 150           | 250       | 250  | 250       | nA max      | with all 0's.   |
| I <sub>OUTB</sub>                                |               |               |               |           | 1  |           |             | II.   |
| + 25°C   | 10            | 10            | 10            | 10        | 10   | 10        | nA max      | DAC B Register loaded   |
| $T_{min}$ to $T_{max}$                           | 150           | 150           | 150           | 250       | 250  | 250       | nA max      | with all 0's.   |
| REFERENCE INPUT                                  |               |               |               |           | <del>                                     </del> |           |             | <del></del> -   |
| Input Resistance                                 | 9             | 9             | 9             | 9         | 9  | 9         | kΩmin       | Typical Input Resistance 14k()  |
| •  | 20            | 20            | 20            | 20        | 20   | 20        | kΩmax       | Typical Input Resistance - 14K11  |
| $V_{REFA}, V_{REFB}$                             |               |               |               |           |  | -~        |             |   |
| Input Resistance Match                           | ± 3           | ± 3           | ± 1           | ± 3       | ± 3  | ± 1       | % max       | Typically ± 0.5%  |
| DIGITAL INPUTS                                   |               | -             |               |           |  | _         |             | - 3.  |
| V <sub>IH</sub> (Input High Voltage)             | 2.4           | 2.4           | 2.4           | 2.4       | 2.4  | 2.4       | V min       |   |
| V <sub>II.</sub> (Input Low Voltage)             | 0.8           |               |               | 0.8       | 0.8  | 0.8       | V min       |   |
| I <sub>IN</sub> (Input Current)                  | 0.0           | 0.0           | 0.8           | 0.8       | 0.8  | 0.8       | Villax      |   |
| + 25°C   | ± 1           | ± 1           | ±1            | ± 1       | ±1   | ± 1       | μA max      | $V_{IN} = V_{DD}$   |
| T <sub>min</sub> to T <sub>max</sub>             | ± 10          | ± 10          | ± 10          | ± 10      | ± 10   | = 10      | μA max      | AIN = ADD   |
| C <sub>IN</sub> (Input Capacitance) <sup>2</sup> | 10            |               | 10            | 10        | 10   | 10        | pF max      |   |
|  |               |               |               |           | ļ  | 1"        | Pillax      |   |
| POWER SUPPLY <sup>3</sup>                        | 1,000,65      | 10000         |               |           | l  | l         |             |   |
| $V_{DD}$   | 10.8/16.5     | 10.8/16.5     | 10.8/16.5     | 10.8/16.5 | 10.8/16.5  | 10.8/16.5 | V min/V max |   |
| $I_{ m DD}$                                      | 2             | 2             | 2             | 2         | 2  | 2         | mA max      |   |

### **AC PERFORMANCE CHARACTERISTICS**

These characteristics are included for Design Guidance only and are not subject to test.

 $(V_{DD} = +12V \text{ to } +15V; V_{REFA} = V_{REFB} = +10V, I_{OUTA} = I_{OUTB} = AGND = 0V.$  Output Amplifiers are AD644 except where stated.)

| Parameter                                     | $T_A = +25^{\circ}C$                    | $T_A = T_{min}, T_{max}$ | Units              | Test Conditions/Comments  |
|---|---|--------------------------|--------------------|---|
| Output Current Settling Time                  | 1.5                                     | -                        | μs max             | To 0.01% of full-scale range. $I_{OUT}$ load = $100\Omega$ , $C_{EXT}$ = $13pF$ DAC output measured from rising edge of $\overline{WR}$ . Typical Value of Settling Time is $0.8\mu s$ .  |
| Digital-to-Analog Glitch Impulse              | 7                                       | -                        | nV-s typ           | $\begin{aligned} & \text{Measured with V}_{REFA} = \text{V}_{REFB} = 0\text{V. I}_{OUTA}, I_{OUTB} \\ & \text{load} = 100\Omega, C_{EXT} = 13\text{pF. DAC registers alternately} \\ & \text{loaded with all 0's and all 1's.} \end{aligned}$ |
| AC Feedthrough <sup>4</sup>                   |   |                          |                    |   |
| V <sub>REFA</sub> to I <sub>OUTA</sub>        | - 70                                    | - 65                     | dB max             | $V_{REFA}$ , $V_{REFB} = 20V_{p-p}$ 10kHz sinewave. DAC   |
| V <sub>REFB</sub> to I <sub>OUTB</sub>        | 70                                      | - 65                     | dB max             | registers loaded with all 0's.  |
| Power Supply Rejection                        |   |                          |                    |   |
| $\Delta Gain/\Delta V_{DD}$                   | ± 0.01                                  | ± 0.02                   | % per % max        | $\Delta V_{\mathrm{DD}} = V_{\mathrm{DD}}  \mathrm{max}  - V_{\mathrm{DD}}  \mathrm{min}$   |
| Output Capacitance                            | *************************************** |                          |                    |   |
| $C_{OUTA}$                                    | 70                                      | 70                       | pF max             | DAC A, DAC B loaded with all 0's.   |
| $C_{OUTB}$                                    | 70                                      | 70                       | pF max             |   |
| Couta   | 140                                     | 140                      | pF max             | DAC A, DAC B loaded with all 1's.   |
| $C_{OUTB}$                                    | 140                                     | 140                      | pF max             |   |
| Channel-to-Channel Isolation                  |   |                          |                    |   |
| $ m V_{REFA}$ to $ m I_{OUTB}$                | - 84                                    | _                        | dB typ             | $V_{REFA} = 20V$ p-p 10kHz sinewave, $V_{REFB} = 0V$ .<br>Both DACs loaded with all 1's.  |
| V <sub>REFB</sub> to I <sub>OUTA</sub>        | - 84                                    | _                        | dB typ             | $V_{REFA} = 20V p - p 10kHz sinewave, V_{REFA} = 0V.$ Both DACs loaded with all 1's.  |
| Digital Crosstalk                             | 7                                       | -                        | nV-s typ           | Measured for a Code Transition of all 0's to all 1's. $I_{OUTA}, I_{OUTB}$ Load = $100\Omega, C_{EXT} = 13pF$   |
| Output Noise Voltage Density<br>(10Hz-100kHz) | 25                                      | _                        | $nV/\sqrt{Hz}$ typ | Measured between R <sub>FBA</sub> and I <sub>OUTA</sub> or R <sub>FBB</sub> and I <sub>OUTB</sub> .<br>Frequency of measurement is 10Hz–100kHz.   |
| Total Harmonic Distortion                     | - 82                                    | _                        | dB typ             | V <sub>IN</sub> = 6V rms, 1kHz. Both DACs loaded with all 1s.   |

#### NOTES

S, T, U Versions: -55°C to +125°C.

Temperature range as follows: J, K, L Versions: -40°C to +85°C. A, B, C Versions: -40°C to +85°C.

<sup>&</sup>lt;sup>2</sup>Sample tested at 25°C to ensure compliance.

<sup>&</sup>lt;sup>3</sup>Functional at V<sub>DD</sub> = 5V with degraded specifications. <sup>4</sup>Pin 12 (DGND) on ceramic DIPs is connected to lid.

Specifications subject to change without notice.

## TIMING CHARACTERISTICS ( $V_{DD} = 10.8V$ to 16.5V, $V_{REFA} = V_{REFB} = +10V$ , $I_{OUTA} = I_{OUTB} = AGND = 0V$ )

| Parameter | Limit at<br>T <sub>A</sub> = +25°C | Limit at $T_A = -40^{\circ}C$ to +85°C | Limit at $T_A = -55^{\circ}C$ to +125°C | Units  | Test Conditions/Comments        |
|-----------|------------------------------------|--|---|--------|---------------------------------|
| 1         | 60                                 | 80                                     | 80                                      | ns min | Data Setup Time                 |
| 2         | 25                                 | 25                                     | 25                                      | ns min | Data Hold Time                  |
| -<br>:3   | 80                                 | 80                                     | 100                                     | ns min | Chip Select to Write Setup Time |
| <u> </u>  | 0                                  | 0                                      | 0                                       | ns min | Chip Select to Write Hold Time  |
| [<        | 80                                 | 80                                     | 100                                     | ns min | Write Pulse Width               |

NOTE

Specifications subject to change without notice.

#### ABSOLUTE MAXIMUM RATINGS\*

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 

| $V_{DD}$ to DGND0.3V, +17V                                 |
|--|
| $V_{REFA}$ , $V_{REFB}$ to AGND,                           |
| $V_{RFBA}$ , $V_{RFBB}$ to AGND,                           |
| Digital Input Voltage to DGND $\dots -0.3V, V_{DD} + 0.3V$ |
| $I_{OUTA},I_{OUTB}$ to DGND $$ $-0.3V,V_{DD}$ $+0.3V$      |
| AGND to DGND $-0.3V$ , $V_{DD}$ $+0.3V$                    |
| Power Dissipation (Any Package)                            |
| To +75°C   |
| Derates above +75°C 6mW/°C                                 |
| Operating Temperature Range                                |
| Commercial Plastic (J, K, L Versions)40°C to +85°C         |

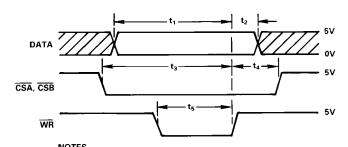
Industrial Hermetic (A, B, C Versions) . . . . -40°C to +85°C Extended Hermetic (S, T, U Versions) . . . . -55°C to +125°C Storage Temperature . . . . . . . . . . . . . .  $-65^{\circ}$ C to  $+150^{\circ}$ C Lead Temperature (Soldering, 10secs) . . . . . . . . + 300°C

\*Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

| CSA      | CSB      | WR         | FUNCTION  |
|----------|----------|------------|---|
| X        | x        | 1          | No Data Transfer  |
| 1        | 1        | X          | No Data Transfer  |
| <b>★</b> | <b> </b> | 0          | A Rising Edge on $\overline{\text{CSA}}$ or $\overline{\text{CSB}}$ Loads |
|          | -        |            | Data to the Respective DAC from the Data Bus                              |
| 0        | 1        | _ <b>-</b> | DAC A Register Loaded from Data Bus                                       |
| 1        | 0        |            | DAC B Register Loaded from Data Bus                                       |
| 0        | 0        |            | DAC A and DAC B Registers Loaded  |
|          |          |            | from Data Bus   |

**NOTES** 

Table I. AD7547 Truth Table



1. ALL INPUT SIGNAL RISE AND FALL TIMES MEASURED FROM 10% TO 90% OF +5V.  $t_r=t_f=20ns.$ 2. TIMING MEASUREMENT REFERENCE LEVEL IS  $\frac{V_{\rm M}+V_{\rm L}}{2}$ 

Figure 1. Timing Diagram for AD7547

#### ORDERING GUIDE<sup>1</sup>

| Model <sup>2</sup> | Temperature<br>Range                          | Relative<br>Accuracy | Gain<br>Error | Package<br>Option <sup>3</sup> |
|--------------------|---|----------------------|---------------|--------------------------------|
| AD7547IN           | -40°C to +85°C                                | ± 1LSB               | ±6LSB         | N-24                           |
| AD7547KN           | -40°C to +85°C                                | ± 1/2LSB             | ± 3LSB        | N-24                           |
| AD7547LN           | -40°C to +85°C                                | $\pm 1/2LSB$         | ± 1LSB        | N-24                           |
| AD7547JP           | -40°C to +85°C                                | ± 1LSB               | ± 6LSB        | P-28A                          |
| AD7547KP           | -40°C to +85°C                                | ± 1/2LSB             | ± 3LSB        | P-28A                          |
| AD7547LP           | -40°C to +85°C                                | $\pm 1/2$ LSB        | ± 1LSB        | P-28A                          |
| AD7547 JR          | -40°C to +85°C                                | ± 1LSB               | ±6LSB         | R-24                           |
| AD7547KR           | -40°C to +85°C                                | ± 1/2LSB             | ± 3LSB        | R-24                           |
| AD7547LR           | -40°C to +85°C                                | ± 1/2LSB             | ± 1LSB        | R-24                           |
| AD7547AQ           | -40°C to +85°C                                | ± 1LSB               | ±6LSB         | O-24                           |
| AD7547BQ           | -40°C to +85°C                                | ± 1/2LSB             | ± 3LSB        | O-24                           |
| AD7547CO           | $-40^{\circ}\text{C to} + 85^{\circ}\text{C}$ | ± 1/2LSB             | ± 1LSB        | O-24                           |
| AD7547SQ           | - 55°C to + 125°C                             | ± 1LSB               | ±6LSB         | Q-24                           |
| AD7547TO           | -55°C to +125°C                               | ± 1/2LSB             | ± 3LSB        | Q-24                           |
| AD7547UQ           | -55°C to +125°C                               | ± 1/2LSB             | ±2LSB         | Q-24                           |
| AD7547SE           | -55°C to +125°C                               | ± 1LSB               | ±6LSB         | E-28A                          |
| AD7547TE           | -55°C to +125°C                               | ± 1/2LSB             | ± 3LSB        | E-28A                          |
| AD7547UE           | − 55°C to + 125°C                             | ± 1/2LSB             | ±2LSB         | E-28A                          |

NOTES

<sup>1</sup>Analog Devices reserves the right to ship ceramic packages (D-24A) in lieu of cerdip packages (Q-24).

<sup>2</sup>To order MIL-STD-883, Class B processed parts, add /883B to part number. Contact your local sales office for military data sheets.

<sup>3</sup>E = Leadless Ceramic Chip Carrier; N = Plastic DIP; P = Plastic Leaded Chip Carrier; Q = Cerdip; R = SOIC.

#### **CAUTION**

ESD (electrostatic discharge) sensitive device. The digital control inputs are diode protected; however, permanent damage may occur on unconnected devices subject to high energy electrostatic fields. Unused devices must be stored in conductive foam or shunts. The protective foam should be discharged to the destination socket before devices are removed.

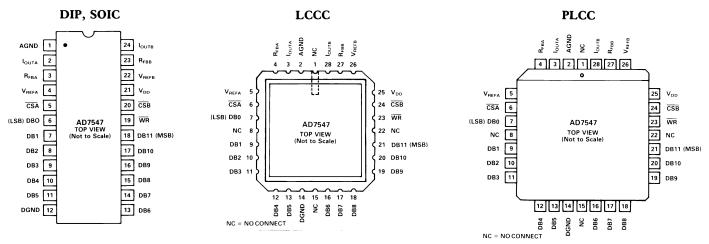


<sup>1.</sup> X = Don't care

<sup>2.</sup> \_ means rising edge triggered

### AD7547

#### PIN CONFIGURATIONS



#### PIN FUNCTION DESCRIPTION (DIP)

| PIN  | MNEMONIC                                     | DESCRIPTION  |
|------|--|--|
| 1    | AGND   | Analog Ground.   |
| 2    | $I_{OUTA}$                                   | Current output terminal of DACA.   |
| 3    | $R_{FBA}$                                    | Feedback resistor for DACA.  |
| 4    | $V_{REFA}$                                   | Reference input to DACA.   |
| 5    | $\overline{CSA}$                             | Chip Select Input for DAC A. Active low.   |
| 6-18 | DB0-DB11                                     | 12 data inputs, DB0 (LSB) – DB11 (MSB).  |
| 12   | DGND   | Digital Ground.  |
| 19   | $\overline{\mathbf{W}}\overline{\mathbf{R}}$ | Write Input. Data transfer occurs on rising edge of $\overline{WR}$ . See Table I. |
| 20   | $\overline{\text{CSB}}$                      | Chip Select Input for DACB. Active low.  |
| 21   | $V_{ m DD}$                                  | Power supply input. Nominally $+ 12V$ to $+ 15V$ with $\pm 10\%$ tolerance.        |
| 22   | $V_{REFB}$                                   | Reference input to DACB.   |
| 23   | $R_{FBB}$                                    | Feedback resistor of DACB.   |
| 24   | $I_{OUTB}$                                   | Current output terminal of DACB.   |
|      |  |  |

#### **CIRCUIT INFORMATION**

#### D/A SECTION

The AD7547 contains two identical 12-bit multiplying D/A converters. Each DAC consists of a highly stable R-2R ladder and 12 N-channel current steering switches. Figure 2 shows a simplified D/A circuit for DAC A. In the R-2R ladder, binary weighted currents are steered between  $I_{\rm OUTA}$  and AGND. The current flowing in each ladder leg is constant, irrespective of switch state. The feedback resistor  $R_{\rm FBA}$  is used with an op-amp (see Figures 4 and 5) to convert the current flowing in  $I_{\rm OUTA}$  to a voltage output.

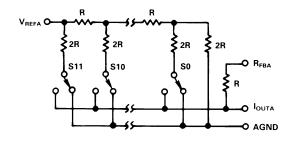


Figure 2. Simplified Circuit Diagram for DACA

#### **EQUIVALENT CIRCUIT ANALYSIS**

Figure 3 shows the equivalent circuit for one of the D/A converters (DAC A) in the AD7547. A similar equivalent circuit can be drawn for DACB. Note that AGND is common to both DAC A and DAC B.

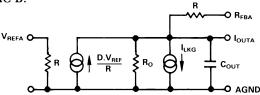


Figure 3. Equivalent Analog Circuit for DACA

 $C_{\rm OUT}$  is the output capacitance due to the N-channel switches and varies from about 50pF to 150pF with digital input code. The current source  $I_{\rm LKG}$  is composed of surface and junction leakages and approximately doubles every 10°C.  $R_0$  is the equivalent output resistance of the device which varies with input code.

#### DIGITAL CIRCUIT INFORMATION

The digital inputs are designed to be both TTL and 5V CMOS compatible. All logic inputs are static-protected MOS gates with typical input currents of less than lnA.

4– REV. A

## UNIPOLAR BINARY OPERATION (2-QUADRANT MULTIPLICATION)

Figure 4 shows the circuit diagram for unipolar binary operation. With an ac input, the circuit performs 2-quadrant multiplication. The code table for Figure 4 is given in Table II.

Operational amplifiers A1 and A2 can be in a single package (AD644, AD712) or separate packages (AD544, AD711, AD OP-27). Capacitors C1 and C2 provide phase compensation to help prevent overshoot and ringing when high speed op-amps are used.

For zero offset adjustment, the appropriate DAC register is loaded with all 0's and amplifier offset adjusted so that  $V_{\rm OUTA}$  or  $V_{\rm OUTB}$  is 0V. Full-scale trimming is accomplished by loading the DAC register with all 1's and adjusting R1 (R3) so that  $V_{\rm OUTA}~(V_{\rm OUTB}) = -V_{\rm IN}~(4095/4096).$  For high temperature operation, resistors and potentiometers should have a low Temperature Coefficient. In many applications, because of the excellent Gain T.C. and Gain Error specifications of the AD7547, Gain Error trimming is not necessary. In fixed reference applications, full-scale can also be adjusted by omitting R1, R2, R3, R4 and trimming the reference voltage magnitude.

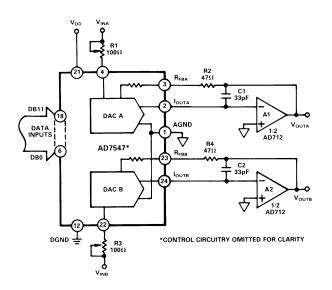


Figure 4. AD7547 Unipolar Binary Operation

| Binary Number in<br>DAC Register<br>MSB LSB | Analog Output, V <sub>OUTA</sub> or V <sub>OUTB</sub>             |
|---|---|
| 1111 1111 1111                              | $-V_{IN}\left(\frac{4095}{4096}\right)$                           |
| 1000 0000 0000                              | $-V_{\rm IN} \left( \frac{2048}{4096} \right) = -1/2  V_{\rm IN}$ |
| 0000 0000 0001                              | $-V_{IN}\Big(\frac{1}{4096}\Big)$                                 |
| 0000 0000 0000                              | 0V  |

Table II. Unipolar Binary Code Table for Circuit of Figure 4

## BIPOLAR OPERATION (4-QUADRANT MULTIPLICATION)

The recommended circuit diagram for bipolar operation is shown in Figure 5. Offset binary coding is used.

With the appropriate DAC register loaded to 1000 0000 0000, adjust R1 (R3) so that  $V_{\rm OUTA}$  ( $V_{\rm OUTB}$ ) = 0V. Alternatively, R1, R2 (R3, R4) may be omitted and the ratios of R6, R7 (R9, R10) varied for  $V_{\rm OUTA}$  ( $V_{\rm OUTB}$ ) = 0V. Full-scale trimming can be accomplished by adjusting the amplitude of  $V_{\rm IN}$  or by varying the value of R5 (R8).

If R1, R2 (R3, R4) are not used, then resistors R5, R6, R7 (R8, R9, R10) should be ratio matched to 0.01% to ensure gain error performance to the data sheet specification. When operating over a wide temperature range, it is important that the resistors be of the same type so that their temperature coefficients match.

The code table for Figure 5 is given in Table III.

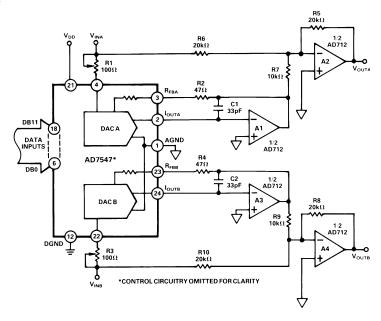


Figure 5. Bipolar Operation (Offset Binary Coding)

| Binary Number in<br>DAC Register<br>MSB LSB | Analog Output,<br>V <sub>OUTA</sub> or V <sub>OUTB</sub> |
|---|--|
| 1111 1111 1111                              | $+ V_{IN} \left( \frac{2047}{2048} \right)$              |
| 1000 0000 0001                              | $+V_{IN}\left(\frac{1}{2048}\right)$                     |
| 1000 0000 0000                              | ov   |
| 0111 1111 1111                              | $-V_{IN}\left(\frac{1}{2048}\right)$                     |
| 0000 0000 0000                              | $-V_{IN} \left( \frac{2048}{2048} \right) = -V_{IN}$     |

Table III. Bipolar Code Table for Offset Binary Circuit of Figure 5.

## **AD7547** — **Applications**

#### PROGRAMMABLE STATE VARIABLE FILTER

The circuit shown in Figure 6 provides three filter outputs: low pass, high pass and bandpass. It is called a State Variable Filter and the particular version shown in Figure 6 uses two AD7547s to control the critical parameters  $f_{\rm o}$ , Q and  $A_{\rm 0}$ . Instead of several fixed resistors, the circuit uses the DAC equivalent resistances as circuit elements. Thus, R1 in Figure 6 is controlled by the 12-bit digital word loaded to DAC A of the AD7547. This is also the case with R2, R3 and R4. The fixed resistor R5 is the feedback resistor,  $R_{\rm FBB}$ .

DAC Equivalent Resistance, Req = 
$$\frac{4096 \times R_{LAD}}{N}$$

where  $R_{LAD} = DAC$  Ladder Resistance

N = DAC Digital Code in Decimal. (0<N<4095)

In the circuit of Figure 6:

C1 = C2, R7 = R8, R3 = R4 (i.e., the same code is in each DAC)

Resonant frequency, 
$$f_o = \frac{1}{2\pi R3 C1}$$

Quality Factor, 
$$Q = \frac{R6}{R8} \cdot \frac{R2}{R5}$$

Bandpass Gain, 
$$A_O = \frac{-R2}{R1}$$

Using the values shown in Figure 6 the Q range is 0.3 to 5 and  $f_o$  range is 0 to 12kHz.

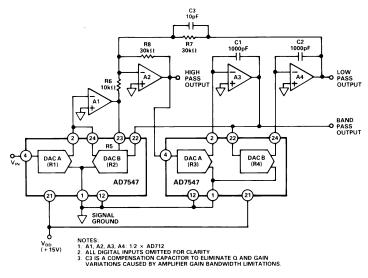


Figure 6. Programmable State Variable Filter

#### SINGLE SUPPLY APPLICATIONS

DAC A and DAC B of the AD7547 have termination resistors which are tied to the AGND line within the device. This arrangement is ideal for single supply operation because AGND may be biased at any voltage between DGND and  $V_{\rm DD}$ . Figure 7 shows a circuit which provides two +5V to +10V analog

outputs by biasing AGND to +5V with respect to DGND, which in this case is also the system ground. The two DAC reference inputs are also tied to system ground.

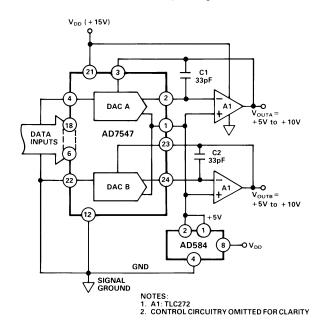


Figure 7. AD7547 Single Supply Operation

The transfer function for each channel is:

$$V_{OUT} = 5V \left( \frac{1 + R_{FB}}{R_{EO}} \right)$$

With all 0's loaded to the DAC,  $R_{EQ}=\infty$  and  $V_{OUT}=+5V$ . With all 1's loaded  $R_{EQ}=R_{LADDER}=R_{FB}$  and  $V_{OUT}=+10V$ .

Figure 8 shows both DACs of the AD7547 connected in the voltage switching mode. For further information on this mode of operation see the CMOS DAC Application Guide from Analog Devices, publication number G872a-15-4/86. To optmize performance when using this circuit,  $V_{\rm IN}$  must be in the range 0 to +1.25V and the output buffered.  $V_{\rm IN}$  must be driven from a low impedance source (e.g. a buffer amplifier). Figure 9 shows how differential linearity degrades with increasing  $V_{\rm IN}$ .

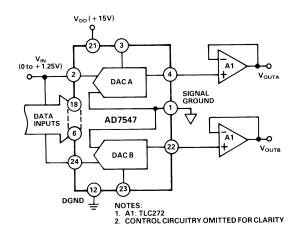


Figure 8. AD7547 Operated in Single Supply, Voltage Switching Mode

**-6-** REV. A

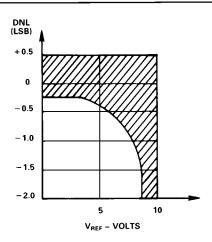


Figure 9. Differential Nonlinearity vs. Reference Voltage for Circuit of Figure 8.  $V_{DD} = 15V$ . Shaded Area Shows Range of Values of Differential Nonlinearity that Typically Occur for L, C and U Grades

#### APPLICATION HINTS

Output Offset: CMOS D/A converters in circuits such as Figures 4 and 5 exhibit a code dependent output resistance which in turn can cause a code dependent error voltage at the output of the amplifier. The maximum amplitude of this error, which adds to the D/A converter nonlinearity, depends on  $V_{\rm OS}$ , where  $V_{\rm OS}$  is the amplifier input offset voltage. To maintain specified operation, it is recommended that  $V_{\rm OS}$  be no greater than  $(25\times 10^{-6})(V_{\rm REF})$  over the temperature range of operation. Suitable op amps are the AD711C and its dual version, the AD712C. These op amps have a wide bandwidth and high slew rate and are recommended for wide bandwidth ac applications. AD711/ AD712 settling time to 0.01% is typically  $1\mu s$ .

Temperature Coefficients: The gain temperature coefficient of the AD7547 has a maximum value of 5ppm/°C and typical value of 1ppm/°C. This corresponds to worst case gain shifts of 2LSBs and 0.4LSBs respectively over a 100°C temperature range. When trim resistors R1(R3) and R2(R4) are used to adjust full-scale range as in Figure 4, the temperature coefficient of R1(R3) and R2(R4) should also be taken into account. For further information see "Gain Error and Gain Temperature Coefficient of CMOS Multiplying DACs", Application Note, Publication Number E630c-5-3/86 available from Analog Devices.

High Frequency Considerations: AD7547 output capacitance works in conjunction with the amplifier feedback resistance to add a pole to the open loop response. This can cause ringing or oscillation. Stability can be restored by adding a phase compensation capacitor in parallel with the feedback resistor. This is shown as C1 and C2 in Figures 4 and 5.

Feedthrough: The dynamic performance of the AD7547 depends upon the gain and phase stability of the output amplifier, together with the optimum choice of PC board layout and decoupling components. A suggested printed circuit layout for Figure 4 is shown in Figure 10 which minimizes feedthrough from  $V_{REFA}$ ,  $V_{REFB}$  to the output in multiplying applications.

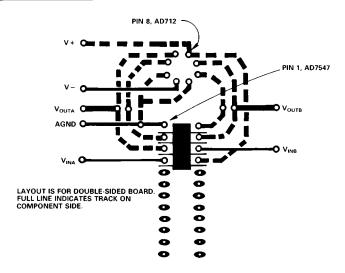


Figure 10. Suggested Layout for Circuit of Figure 4

#### MICROPROCESSOR INTERFACING

The AD7547 is designed for easy interfacing to 16-bit microprocessors. Figures 11 and 12 show the interface circuits for two of the most popular 16-bit microprocessors; the 8086 and the 68000. Note that the amount of external logic needed is minimal.

Since data is loaded into the DAC registers on the rising edge of WR, the possibility of invalid data being loaded temporarily to the DAC is removed. This considerably eases the interface circuit design.

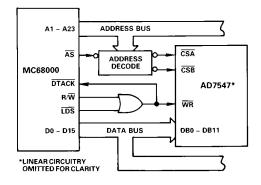


Figure 11. AD7547 - MC68000 Interface

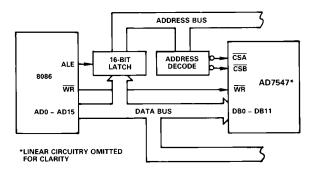
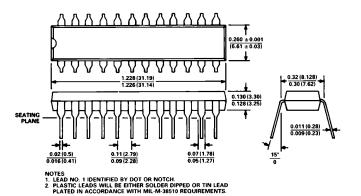


Figure 12. AD7547 - 8086 Interface

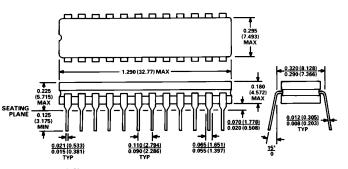
#### **OUTLINE DIMENSIONS**

Dimensions shown in inches and (mm).

#### 24-Pin Plastic DIP (N-24)

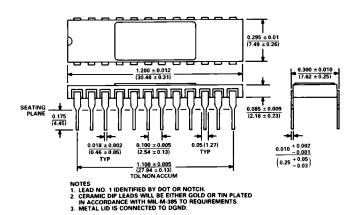


#### 24-Pin Cerdip (Q-24)

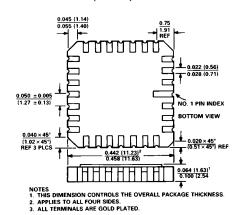


NOTES
1. LEAD NO. 1 IDENTIFIED BY DOT OR NOTCH.
2. CERDIP LEADS WILL BE EITHER TIN PLATED OR SOLDER DIPPED IN ACCORDANCE WITH MIL-M-38510 REQUIREMENTS.

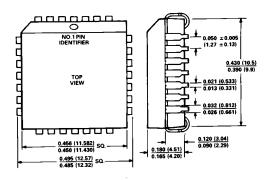
#### 24-Pin Ceramic DIP (D-24A)



## 28-Terminal Leadless Ceramic Chip Carrier (E-28A)



## 28-Terminal Plastic Leaded Chip Carrier (P-28A)



#### **PRICING** (100+) \$

| AD7547JN \$14.50 | AD7547AQ \$19.80 | AD7547SQ \$60.00 |
|------------------|------------------|------------------|
| AD7547KN\$17.00  | AD7547BQ \$22.30 | AD7547TQ \$70.00 |
| AD7547LN \$23.00 | AD7547CQ \$28.30 | AD7547UQ \$85.00 |